

Notice of References Cited	Application/Control No. 10/820,743	Applicant(s)/Patent Under Reexamination LIN ET AL.	
	Examiner Su C. Kim	Art Unit 2823	Page 1 of 1

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	B	US-2005/0035398	02-2005	Williams et al.	257/329
	C	US-6,551,881 B1	04-2003	Letavic, Tod	438/267
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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